

<b>Notice of References Cited</b>	Application/Control No. 10/621,772	Applicant(s)/Patent Under Reexamination O'BRIEN, WAYNE PATRICK	
	Examiner Zheng Wei	Art Unit 2192	Page 1 of 1

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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